

## Monolithic CMOS Analog Switches

The DG401, DG403 and DG405 monolithic CMOS analog switches have TTL and CMOS compatible digital inputs.

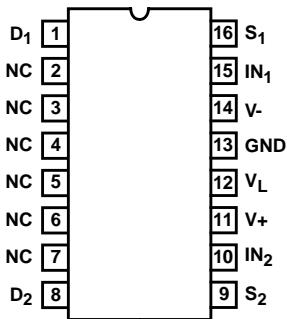
These switches feature low analog ON resistance ( $<45\Omega$ ) and fast switch time ( $t_{ON} < 150\text{ns}$ ). Low charge injection simplifies sample and hold applications.

The improvements in the DG401/403/405 series are made possible by using a high voltage silicon-gate process. An epitaxial layer prevents the latch-up associated with older CMOS technologies. The 44V maximum voltage range permits controlling 30V<sub>P-P</sub> signals. Power supplies may be single-ended from +5V to +34V, or split from  $\pm 5\text{V}$  to  $\pm 17\text{V}$ .

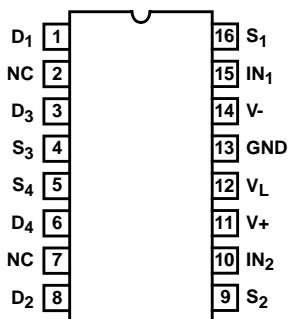
The analog switches are bilateral, equally matched for AC or bidirectional signals. The ON resistance variation with analog signals is quite low over a  $\pm 15\text{V}$  analog input range. The three different devices provide the equivalent of two SPST (DG401), two SPDT (DG403) or two DPST (DG405) relay switch contacts with CMOS or TTL level activation. The pinout is similar, permitting a standard layout to be used, choosing the switch function as needed.

## Pinouts

**DG401 (PDIP, SOIC)**  
TOP VIEW



**DG403, DG405 (SOIC)**  
TOP VIEW



NOTE: (NC) No Connection.

## Features

- ON Resistance (Max) .....  $45\Omega$
- Low Power Consumption ( $P_D$ ) .....  $<35\mu\text{W}$
- Fast Switching Action
  - $t_{ON}$  (Max) ..... 150ns
  - $t_{OFF}$  (Max) ..... 100ns
- Low Charge Injection
- DG401 Dual SPST; Same Pinout as HI-5041
- DG403 Dual SPDT; DG190, IH5043, IH5151, HI-5051
- DG405 Dual DPST; DG184, HI-5045, IH5145
- TTL, CMOS Compatible
- Single or Split Supply Operation

## Applications

- Audio Switching
- Battery Operated Systems
- Data Acquisition
- Hi-Rel Systems
- Sample and Hold Circuits
- Communication Systems
- Automatic Test Equipment

## Ordering Information

PART NUMBER	TEMP. RANGE (°C)	PACKAGE	PKG. NO.
DG401DJ	-40 to 85	16 Ld PDIP	E16.3
DG401DY	-40 to 85	16 Ld SOIC	M16.15
DG403DJ	-40 to 85	16 Ld PDIP	E16.3
DG403DY	-40 to 85	16 Ld SOIC	M16.15
DG405DY	-40 to 85	16 Ld SOIC	M16.15

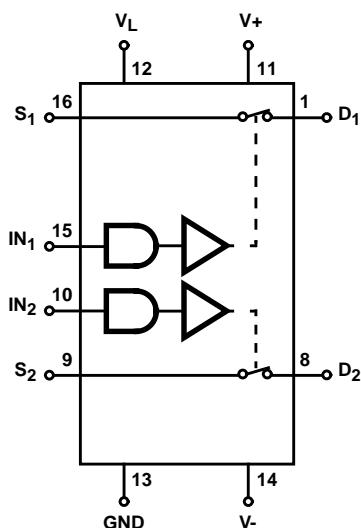
## TRUTH TABLE

LOGIC	DG401		DG403		DG405
	SWITCH	SWITCH	SWITCH 1, 2	SWITCH 3, 4	SWITCH
0	OFF	OFF	ON	ON	OFF
1	ON	ON	OFF	OFF	ON

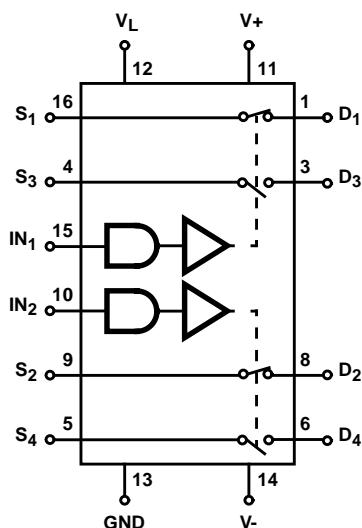
NOTE: Logic "0"  $\leq 0.8\text{V}$ . Logic "1"  $\geq 2.4\text{V}$ .

### Functional Diagrams

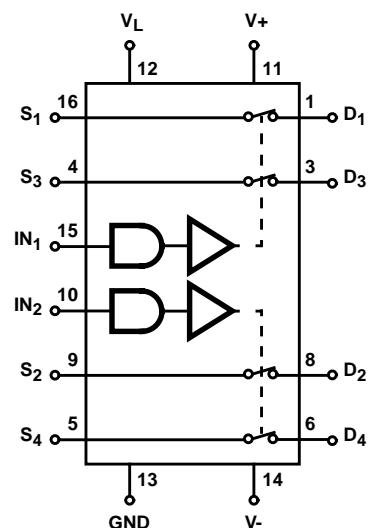
DG401



DG403

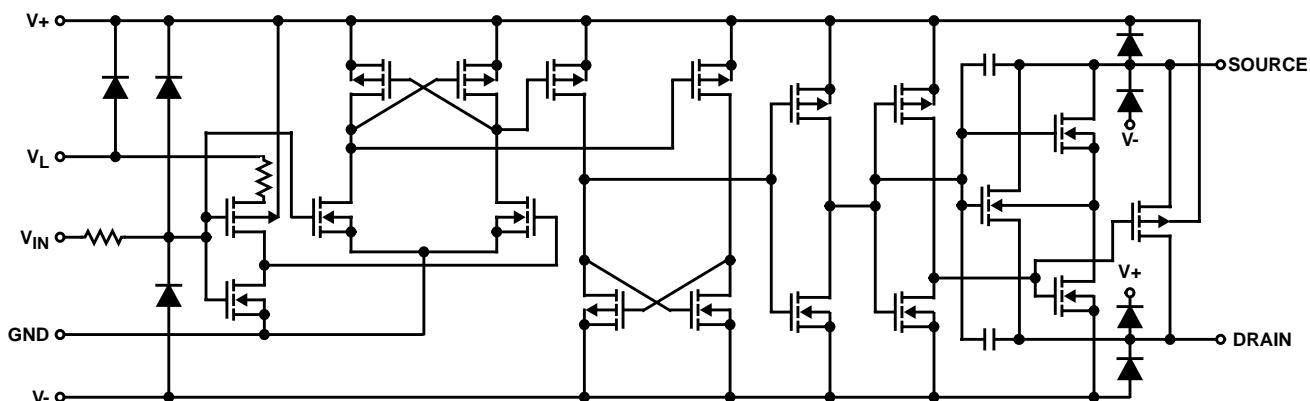


DG405



SWITCHES SHOWN FOR LOGIC "1" INPUT

### Schematic Diagram



## Absolute Maximum Ratings

V+ to V- .....	44.0V
GND to V- .....	25V
V <sub>L</sub> .....	(GND - 0.3V) to (V+) +0.3V
Digital Inputs V <sub>S</sub> , V <sub>D</sub> (Note 1) .....	(V-) -2V to (V+) +2V or 30mA, Whichever Occurs First
Continuous Current (Any Terminal) .....	30mA
Peak Current, S or D (Pulsed 1ms, 10% Duty Cycle, Max) ..	100mA

## Thermal Information

Thermal Resistance (Typical, Note 2)	$\theta_{JA}$ ( $^{\circ}\text{C}/\text{W}$ )
PDIP Package .....	90
SOIC Package .....	115
Maximum Junction Temperature (Plastic Package) .....	150 $^{\circ}\text{C}$
Maximum Storage Temperature Range .....	-65 $^{\circ}\text{C}$ to 150 $^{\circ}\text{C}$
Maximum Lead Temperature (Soldering 10s) .....	300 $^{\circ}\text{C}$
(SOIC - Lead Tips Only)	

## Operating Conditions

Temperature Range .....	-40 $^{\circ}\text{C}$ to 85 $^{\circ}\text{C}$
Voltage Range .....	$\pm 20\text{V}$ (Max)
Input Low Voltage .....	0.8V (Max)
Input High Voltage .....	2.4V (Min)
Input Rise and Fall Time .....	$\leq 20\text{ns}$

**CAUTION:** Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### NOTES:

1. Signals on S<sub>X</sub>, D<sub>X</sub>, or IN<sub>X</sub> exceeding V+ or V- will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
2.  $\theta_{JA}$  is measured with the component mounted on an evaluation PC board in free air.

## Electrical Specifications

Test Conditions: V+ = +15V, V- = -15V, V<sub>IN</sub> = 2.4V, 0.8V (Note 3), V<sub>L</sub> = 5V,  
Unless Otherwise Specified

PARAMETER	TEST CONDITIONS	TEMP ( $^{\circ}\text{C}$ )	(NOTE 4) MIN	(NOTE 5) TYP	(NOTE 4) MAX	UNITS
<b>DYNAMIC CHARACTERISTICS</b>						
Turn-ON Time, t <sub>ON</sub>	R <sub>L</sub> = 300 $\Omega$ , C <sub>L</sub> = 35pF	25	-	100	150	ns
Turn-OFF Time, t <sub>OFF</sub>		25	-	60	100	ns
Break-Before-Make Time Delay (DG403), t <sub>D</sub>	R <sub>L</sub> = 300 $\Omega$ , C <sub>L</sub> = 35pF	25	5	12	-	ns
Charge Injection, Q (Figure 3)	C <sub>L</sub> = 10nF, V <sub>G</sub> = 0V, R <sub>G</sub> = 0 $\Omega$	25	-	60	-	pC
OFF Isolation (Figure 4)	R <sub>L</sub> = 100 $\Omega$ , C <sub>L</sub> = 5pF, f = 1MHz	25	-	72	-	dB
Crosstalk (Channel-to-Channel) (Figure 6)		25	-	-90	-	dB
Source OFF Capacitance, C <sub>S(OFF)</sub>	f = 1MHz, V <sub>S</sub> = V <sub>D</sub> = 0V (Figure 7)	25	-	12	-	pF
Drain OFF Capacitance, C <sub>D(OFF)</sub>		25	-	12	-	pF
Channel ON Capacitance, C <sub>D(ON)</sub> + C <sub>S(ON)</sub>		25	-	39	-	pF
<b>DIGITAL INPUT CHARACTERISTICS</b>						
Input Current with V <sub>IN</sub> Low, I <sub>IL</sub>	V <sub>IN</sub> Under Test = 0.8V, All Others = 2.4V	Full	-1	0.005	1	$\mu\text{A}$
Input Current with V <sub>IN</sub> High, I <sub>IH</sub>	V <sub>IN</sub> Under Test = 2.4V, All Others = 0.8V	Full	-1	0.005	1	$\mu\text{A}$
<b>ANALOG SWITCH CHARACTERISTICS</b>						
Analog Signal Range, V <sub>ANALOG</sub>		Full	-15	-	15	V
Drain-Source ON Resistance, r <sub>DS(ON)</sub>	V+ = 13.5V, V- = -13.5V, I <sub>S</sub> = $\pm 10\text{mA}$ , V <sub>D</sub> = $\pm 10\text{V}$	25	-	20	45	$\Omega$
		Full	-	-	55	$\Omega$
r <sub>DS(ON)</sub> Matching Between Channels, $\Delta r_{DS(ON)}$	V+ = 16.5V, V- = -16.5V, I <sub>S</sub> = -10mA, V <sub>D</sub> = 5, 0, -5V	25	-	3	3	$\Omega$
		Full	-	-	5	$\Omega$
Source OFF Leakage Current, I <sub>S(OFF)</sub>	V+ = 16.5V, V- = -16.5V V <sub>D</sub> = $\pm 15.5\text{V}$ , V <sub>S</sub> = $\pm 15.5\text{V}$	25	-0.5	-0.01	0.5	nA
		Full	-5	-	5	nA
Drain OFF Leakage Current, I <sub>D(OFF)</sub>		25	-0.5	-0.01	0.5	nA
		Full	-5	-	5	nA
Channel ON Leakage Current, I <sub>D(ON)</sub> + I <sub>S(ON)</sub>	V <sub>S</sub> = $\pm 16.5\text{V}$ , V <sub>D</sub> = V <sub>S</sub> = $\pm 15.5\text{V}$	25	-1	-0.04	1	nA
		Full	-10	-	10	nA

**Electrical Specifications**

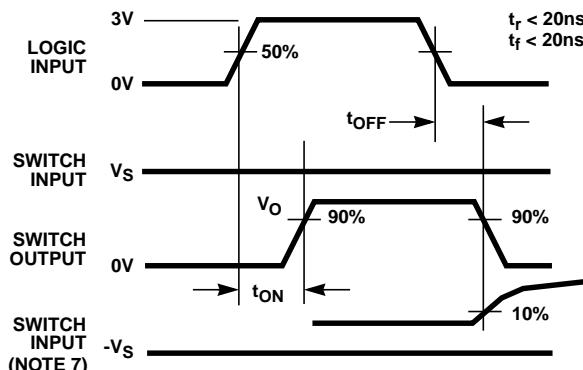
Test Conditions:  $V_+ = +15V$ ,  $V_- = -15V$ ,  $V_{IN} = 2.4V, 0.8V$  (Note 3),  $V_L = 5V$ ,  
Unless Otherwise Specified **(Continued)**

PARAMETER	TEST CONDITIONS	TEMP (°C)	(NOTE 4) MIN	(NOTE 5) TYP	(NOTE 4) MAX	UNITS
<b>POWER SUPPLY CHARACTERISTICS</b>						
Positive Supply Current, $I_+$	$V_+ = 16.5V$ , $V_- = -16.5V$ , $V_{IN} = 0V$ or $5V$	25	-	0.01	1	$\mu A$
		Full	-	-	5	$\mu A$
Negative Supply Current, $I_-$		25	-1	-0.01	-	$\mu A$
		Full	-5	-	-	$\mu A$
Logic Supply Current, $I_L$		25	-	0.01	1	$\mu A$
		Full	-	-	5	$\mu A$
Ground Current, $I_{GND}$		25	-1	-0.01	-	$\mu A$
		Full	-5	-	-	$\mu A$

NOTES:

3.  $V_{IN}$  = input voltage to perform proper function.
4. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
5. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.

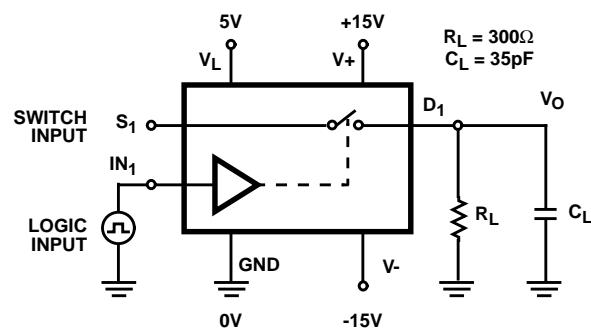
**Test Circuits and Waveforms**



NOTES:

6. Logic input waveform is inverted for switches that have the opposite logic sense.
7.  $V_S = 10V$  for  $t_{ON}$ ,  $V_S = -10V$  for  $t_{OFF}$ .

FIGURE 1A. MEASUREMENT POINTS



Repeat test for  $IN_2$  and  $S_2$ .  
For load conditions, see Specifications.  $C_L$  includes fixture and stray capacitance.

$$V_O = V_S \frac{R_L}{R_L + r_{DS(ON)}}$$

FIGURE 1B. TEST CIRCUIT

FIGURE 1. SWITCHING TIMES

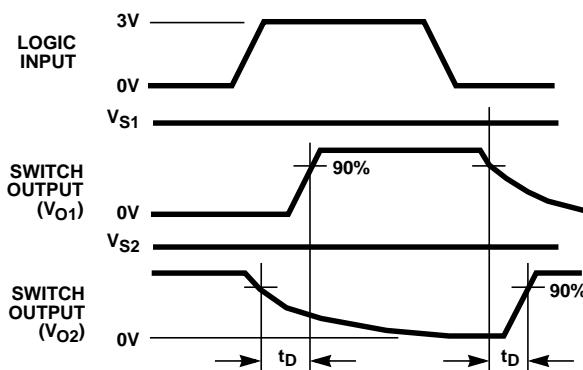
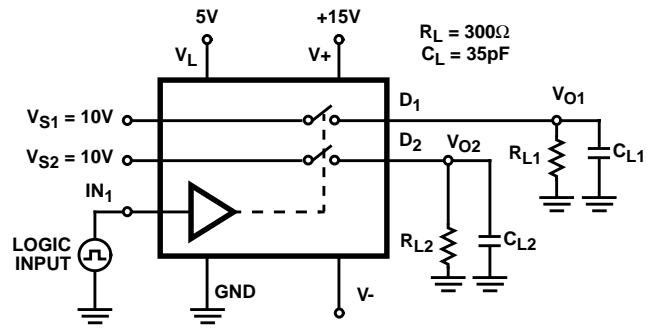


FIGURE 2A. MEASUREMENT POINTS



$C_L$  includes fixture and stray capacitance.

FIGURE 2B. TEST CIRCUIT

FIGURE 2. BREAK-BEFORE-MAKE TIME

**Test Circuits and Waveforms (Continued)**

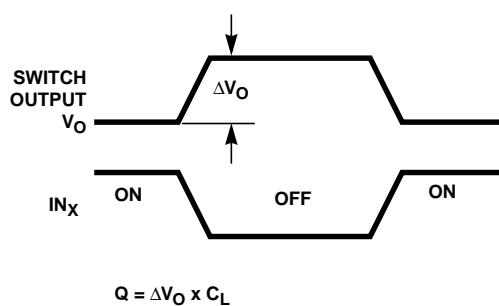


FIGURE 3A. MEASUREMENT POINTS

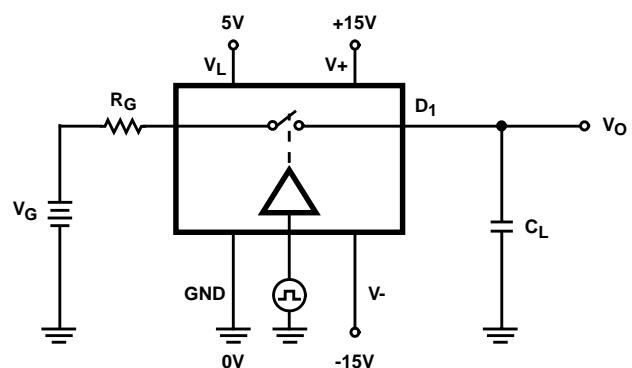


FIGURE 3B. TEST CIRCUIT

FIGURE 3. CHARGE INJECTION

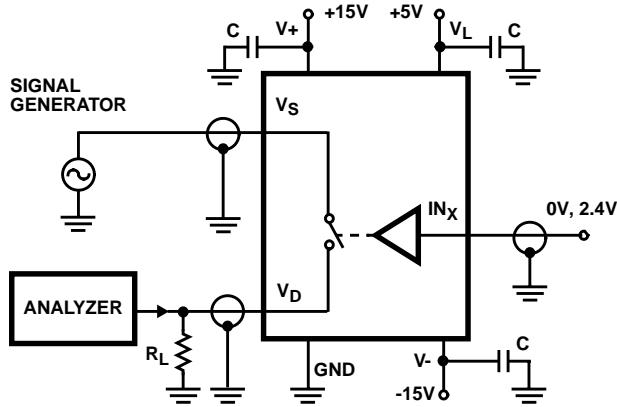


FIGURE 4. OFF ISOLATION TEST CIRCUIT

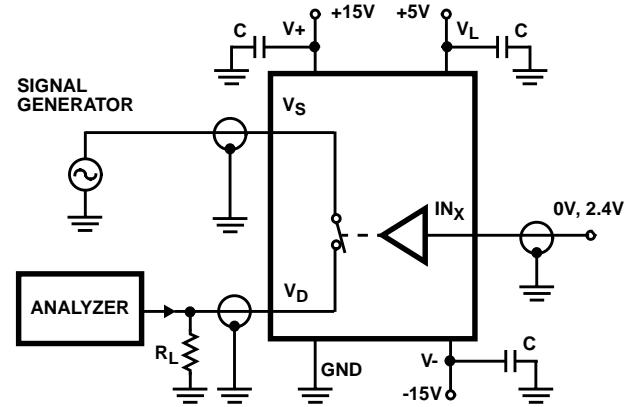


FIGURE 5. INSERTION LOSS TEST CIRCUIT

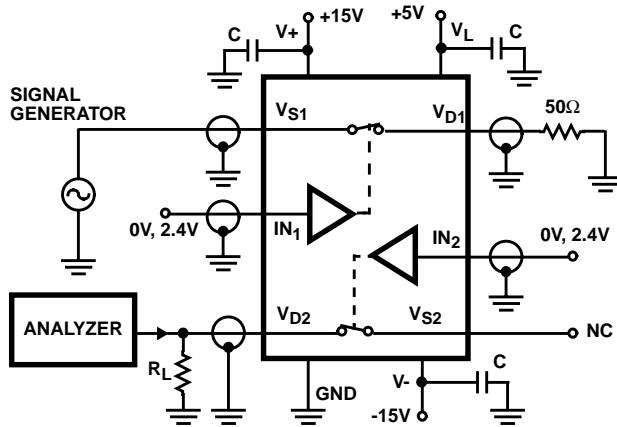


FIGURE 6. CROSSTALK TEST CIRCUIT

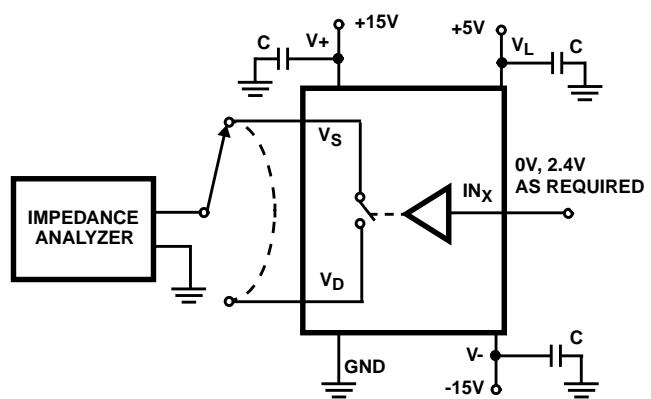


FIGURE 7. CAPACITANCES TEST CIRCUIT

## Application Information

### Dual Slope Integrators

The DG403 is well suited to configure a selectable slope integrator. One control signal selects the timing capacitor  $C_1$  or  $C_2$ . Another one selects  $e_{IN}$  or discharges the capacitor in preparation for the next integration cycle.

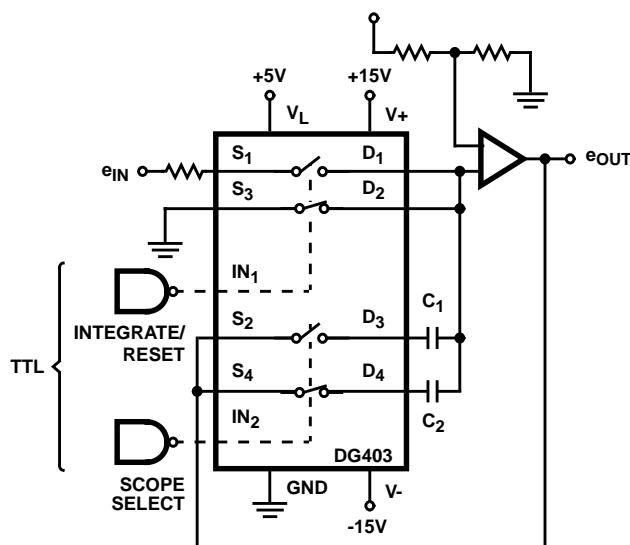


FIGURE 8. DUAL SLOPE INTEGRATOR

### Peak Detector

A<sub>3</sub> acting as a comparator provides the logic drive for operating SW<sub>1</sub>. The output of A<sub>2</sub> is fed back to A<sub>3</sub> and compared to the analog input e<sub>IN</sub>. If e<sub>IN</sub> > e<sub>OUT</sub> the output of A<sub>3</sub> is high keeping SW<sub>1</sub> closed. This allows C<sub>1</sub> to charge up to the analog input voltage. When e<sub>IN</sub> goes below e<sub>OUT</sub>, A<sub>3</sub> goes negative, turning SW<sub>1</sub> off. The system will therefore store the most positive analog input experienced.

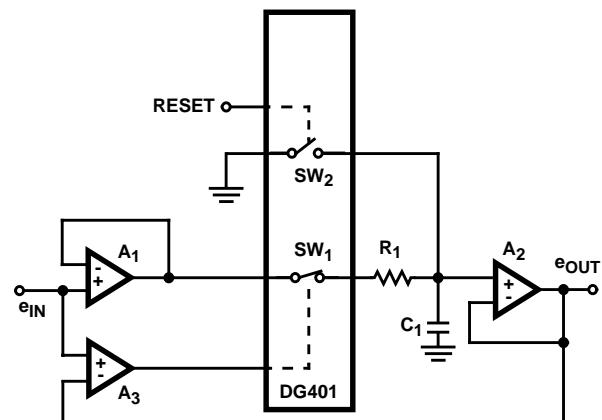


FIGURE 9. POSITIVE PEAK DETECTOR

## Typical Performance Curves

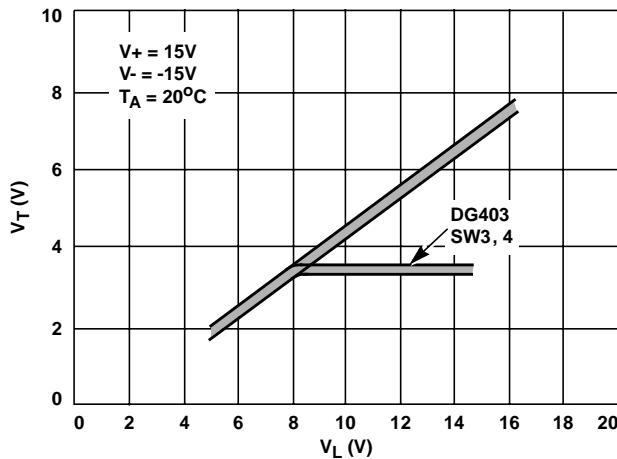


FIGURE 10. INPUT SWITCHING THRESHOLD vs LOGIC SUPPLY VOLTAGE

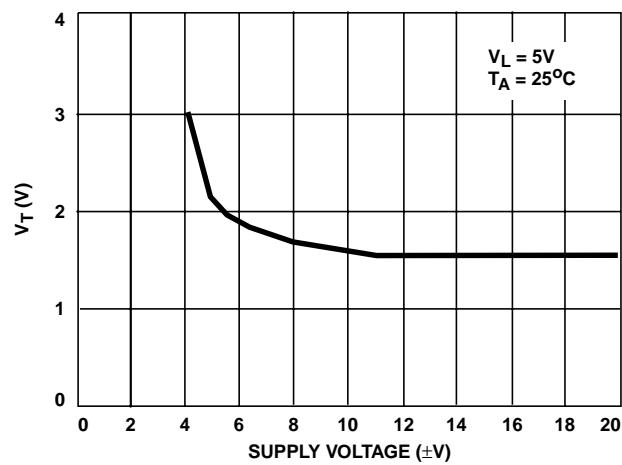


FIGURE 11. INPUT SWITCHING THRESHOLD vs POWER SUPPLY VOLTAGE

**Typical Performance Curves (Continued)**

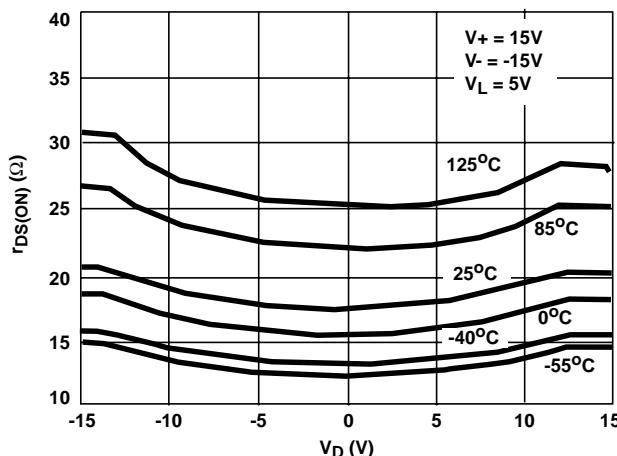


FIGURE 12.  $r_{DS(ON)}$  vs  $V_D$  AND TEMPERATURE

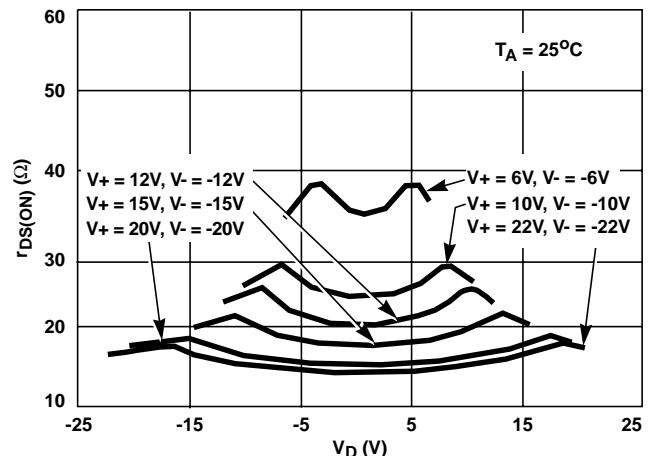


FIGURE 13.  $r_{DS(ON)}$  vs  $V_D$  AND POWER SUPPLY VOLTAGE

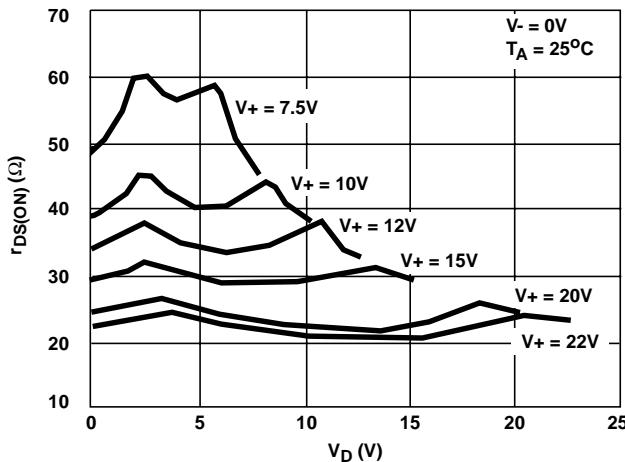


FIGURE 14.  $r_{DS(ON)}$  vs  $V_D$  AND SINGLE SUPPLY VOLTAGE

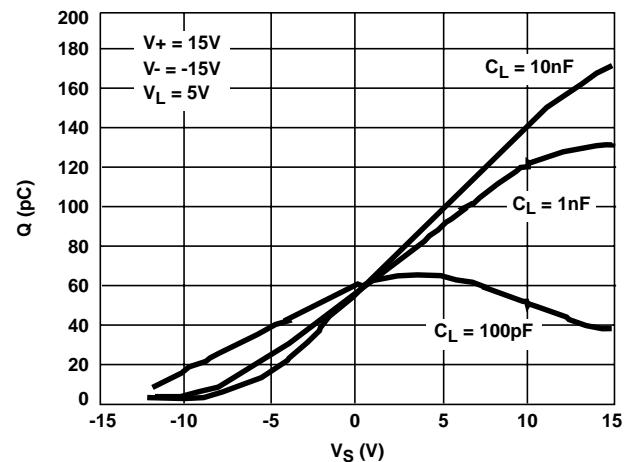


FIGURE 15. CHARGE INJECTION vs SOURCE VOLTAGE

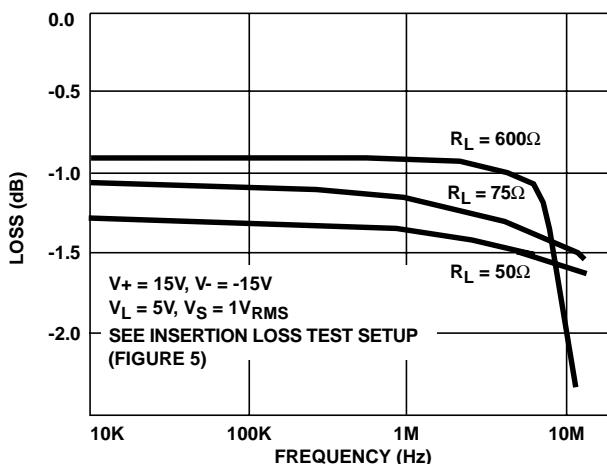


FIGURE 16. INSERTION LOSS vs FREQUENCY

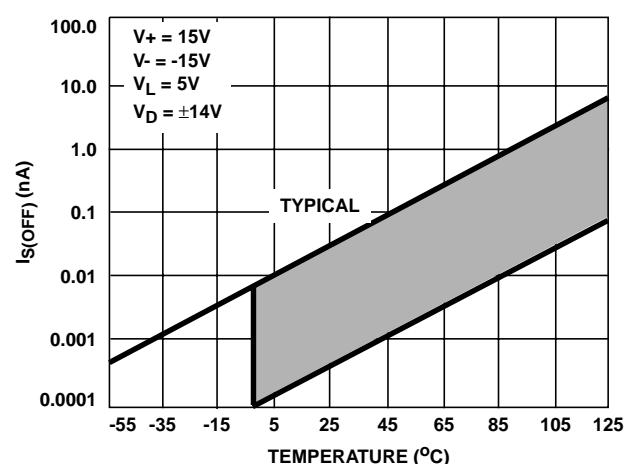


FIGURE 17.  $I_{S(OFF)}$  vs TEMPERATURE

**Typical Performance Curves (Continued)**

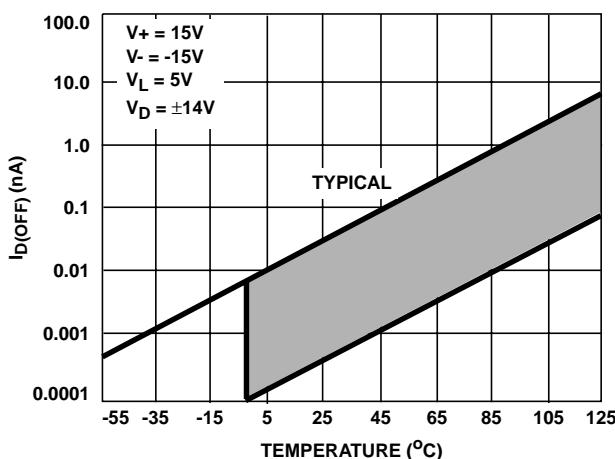


FIGURE 18.  $I_{D(OFF)}$  vs TEMPERATURE

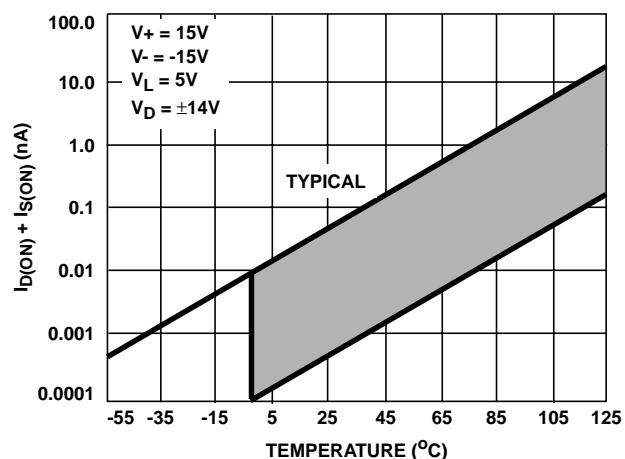


FIGURE 19.  $I_{D(ON)} + I_{S(ON)}$  vs TEMPERATURE

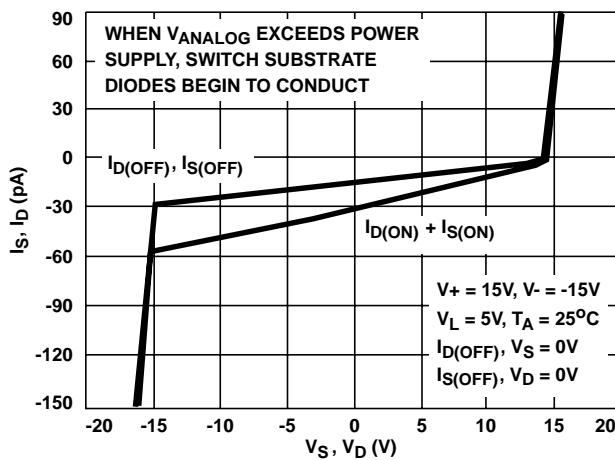


FIGURE 20. LEAKAGE CURRENTS vs ANALOG VOLTAGE

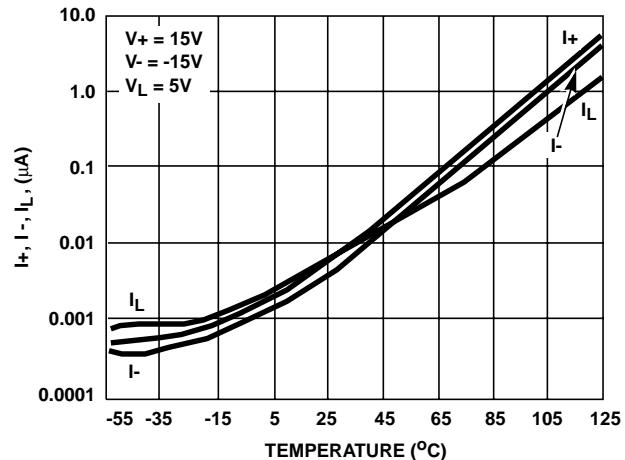


FIGURE 21. SUPPLY CURRENT vs TEMPERATURE

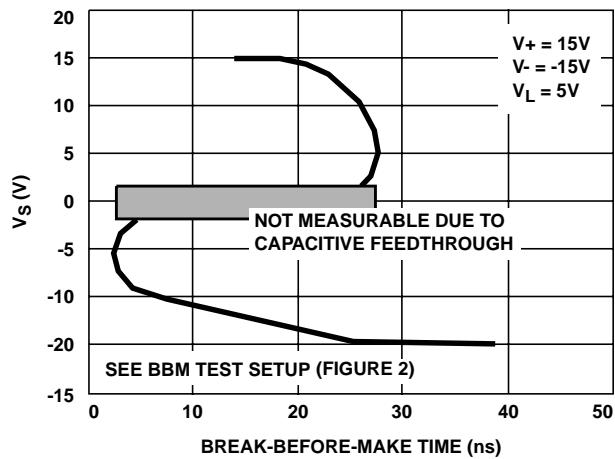


FIGURE 22. BREAK-BEFORE-MAKE vs ANALOG VOLTAGE

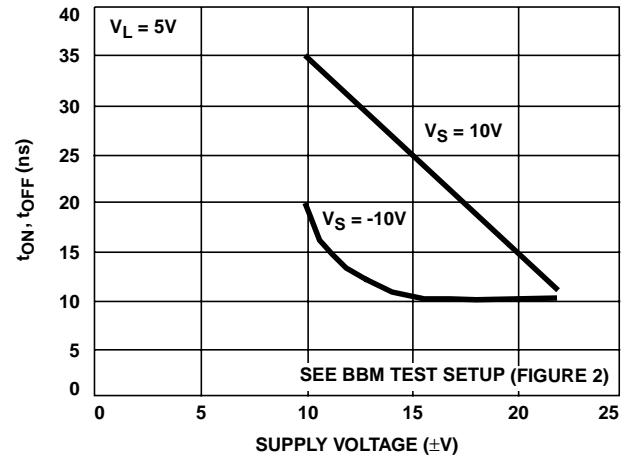
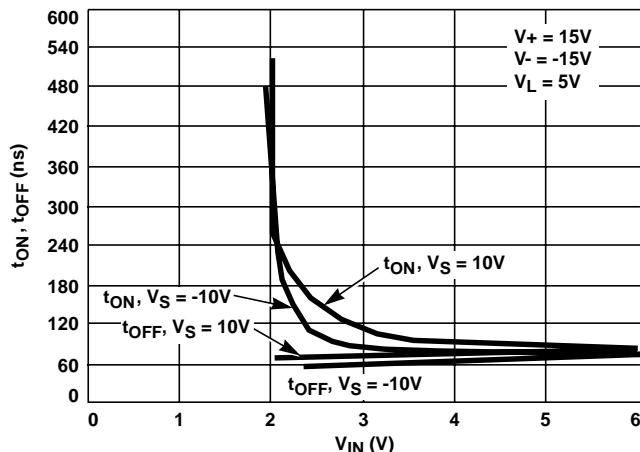
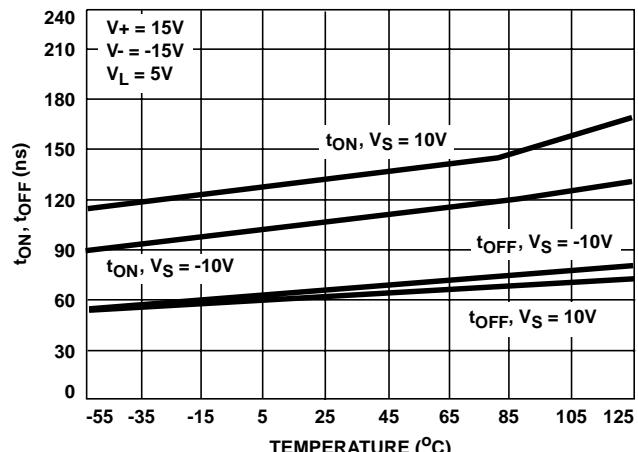


FIGURE 23. BREAK-BEFORE-MAKE vs POWER SUPPLY VOLTAGE

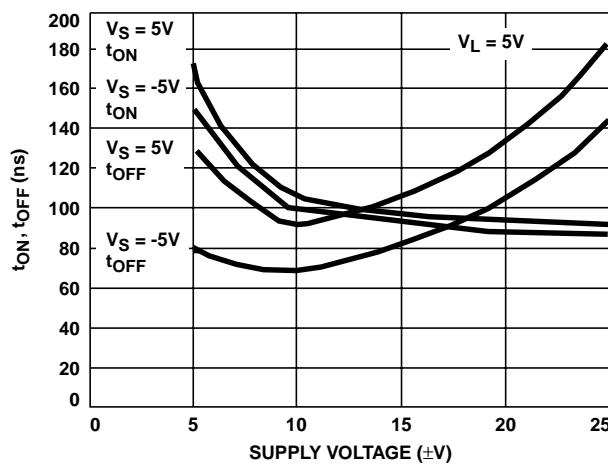
**Typical Performance Curves (Continued)**



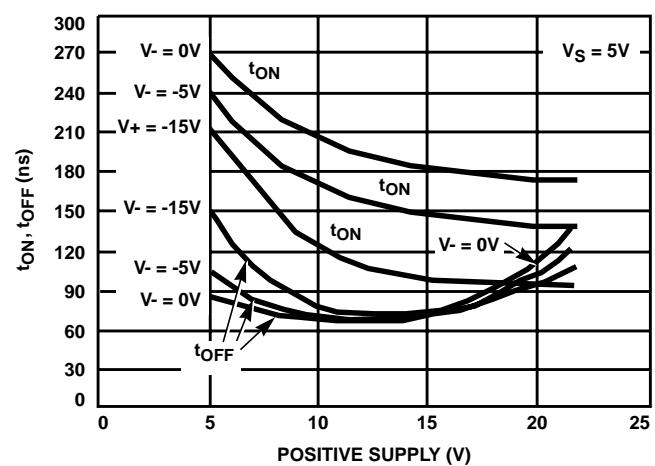
**FIGURE 24. SWITCHING TIME vs INPUT LOGIC VOLTAGE (NOTE 8)**



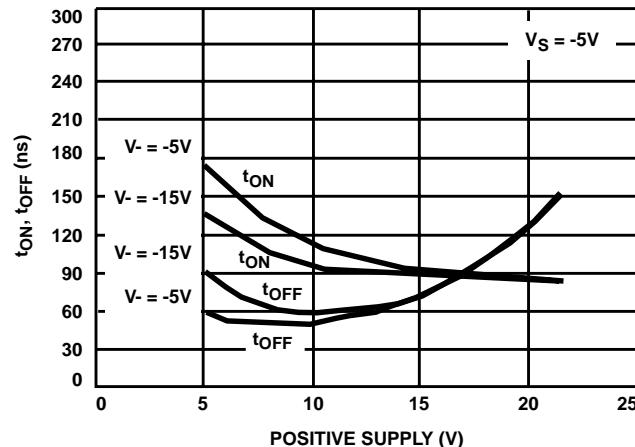
**FIGURE 25. SWITCHING TIME vs TEMPERATURE (NOTE 8)**



**FIGURE 26. SWITCHING TIME vs POWER SUPPLY VOLTAGE (NOTE 8)**



**FIGURE 27. SWITCHING TIME vs POSITIVE SUPPLY VOLTAGE (NOTE 8)**



**FIGURE 28. SWITCHING TIME vs POSITIVE SUPPLY VOLTAGE (NOTE 8)**

NOTE:

8. Refer to Figure 1 for test conditions.

All Intersil semiconductor products are manufactured, assembled and tested under **ISO9000** quality systems certification.

*Intersil semiconductor products are sold by description only. Intersil Corporation reserves the right to make changes in circuit design and/or specifications at any time without notice. Accordingly, the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.*

---

For information regarding Intersil Corporation and its products, see web site <http://www.intersil.com>

### **Sales Office Headquarters**

#### **NORTH AMERICA**

Intersil Corporation  
P. O. Box 883, Mail Stop 53-204  
Melbourne, FL 32902  
TEL: (321) 724-7000  
FAX: (321) 724-7240

#### **EUROPE**

Intersil SA  
Mercure Center  
100, Rue de la Fusée  
1130 Brussels, Belgium  
TEL: (32) 2.724.2111  
FAX: (32) 2.724.22.05

#### **ASIA**

Intersil (Taiwan) Ltd.  
7F-6, No. 101 Fu Hsing North Road  
Taipei, Taiwan  
Republic of China  
TEL: (886) 2 2716 9310  
FAX: (886) 2 2715 3029